## **CLAIM AMENDMENTS**

- 1. (Currently Amended) A method for producing a polishing pad comprising
- (a) providing a porous polymer structure;
- (b) compressing at least a region of the porous polymer structure to provide a translucent region; and
- (c) forming a polishing pad comprising the porous polymer structure, whereby a wherein the polishing pad is so produced comprising comprises the translucent region and a substantially opaque region provided by a non-compressed region of the porous polymer structure.
- 2. (Original) The method of Claim 1 further comprising heating the porous polymer structure.
- 3. (Original) The method of Claim 2, wherein the porous polymer structure is heated to a temperature within about 50°C of its melting temperature.
- 4. (Original) The method of Claim 3, wherein the porous polymer structure is heated to a temperature about 10-50°C above its melting temperature.
- 5. (Previously Presented) The method of Claim 1, wherein the porous polymer structure is compressed to a thickness that is about 10-50% of its thickness prior to compression.
- 6. (Previously Presented) The method of Claim 5, wherein the porous polymer structure is compressed to a thickness that is about 20-40% of its thickness prior to compression.
- 7. (Original) The method of Claim 1, wherein the porous polymer structure is opaque prior to the compression step.
- 8. (Original) The method of Claim 1, wherein the porous polymer structure comprises a thermoplastic.

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- 9. (Original) The method of Claim 8, wherein the porous polymer structure comprises polyurethane.
- 10. (Original) The method of Claim 1 further comprising mating the translucent region to a second polymer structure.

## 11.-12. (Canceled)

- 13. (Currently Amended) The method of Claim 11 1, wherein the substantially opaque region is provided by a material that is different from the porous polymer structure.
- 14. (Currently Amended) The method of Claim 12 1, wherein the translucent region is thinner than the substantially opaque region.
- 15. (Original) The method of Claim 1, further comprising overlaying the region of the porous polymer structure to be compressed with a space-filling material prior to compressing.
- 16. (Original) The method of Claim 15, wherein the porous polymer structure and space-filling material overlaid thereupon are compressed to a thickness about equal to that of the porous polymer structure prior to compressing.
- 17. (Original) The method of Claim 16, wherein the space-filling material is the same as the porous polymer.
- 18. (Original) The method of Claim 1, wherein the porous polymer structure comprises an intrinsic surface texture.
- 19. (Original) The method of Claim 18, wherein the translucent region comprises an intrinsic surface texture.
- 20. (Original) The method of Claim 1, further comprising providing an extrinsic surface texture on at least a portion of the surface of the polishing pad.

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21. (Original) The method of Claim 1, wherein the translucent region is translucent to light having a wavelength of about 190-3500 nm.

## 22.-24. (Canceled)

25. (Currently Amended) A polishing pad comprising a porous polymer structure, the pad comprising a region that is at least translucent and a substantially opaque region, wherein the translucent region is sufficiently porous to absorb or transport a polishing slurry, and wherein at least a portion of the substantially opaque region of the polishing pad is provided by a non-compressed region of the porous polymer structure.

## 26.-28. (Canceled)

- 29. (Currently Amended) The polishing pad of claim 27 25, wherein at least a portion of the substantially opaque region of the polishing pad is provided by a material that is different from the porous polymer structure.
  - 30. (Currently Amended) A method of polishing a substrate comprising
  - (i) contacting a substrate with a polishing pad produced by a method comprising:
    - (a) providing a porous polymer structure;
    - (b) compressing a region of the porous polymer structure to provide a translucent region; and
    - (c) forming a polishing pad comprising the porous polymer structure,

      whereby a wherein the polishing pad is so produced comprising

      comprises the translucent region and a substantially opaque region

      provided by a non-compressed region of the porous polymer structure,

      and
  - (ii) moving the substrate and polishing pad relative to each other.
- 31. (Original) The method of Claim 30, wherein the substrate is a semiconductor device.
- 32. (Original) The method of Claim 31 further comprising passing light through the translucent region of the polishing pad to evaluate the polishing of the substrate.

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- 33. (Original) The method of Claim 32, wherein the light is a laser light.
- 34. (Currently Amended) A method of polishing a substrate comprising (i) contacting a substrate with a polishing pad comprising a porous polymer structure, the pad comprising a region that is at least translucent and a substantially opaque region, wherein the translucent region is sufficiently porous to absorb or transport a polishing slurry, and wherein at least a portion of the substantially opaque region of the polishing pad is provided by a non-compressed region of the porous polymer structure, and (ii) moving the substrate and polishing pad relative to each other.
- 35. (Original) The method of Claim 34, wherein the substrate is a semiconductor device.
- 36. (Original) The method of Claim 35, further comprising passing light through the translucent region of the polishing pad to evaluate the polishing of the substrate.
  - 37. (Original) The method of Claim 36, wherein the light is a laser light.